

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LEE, SEUNG-WOO	
		Examiner Steven E. Holton	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,825,824	11-2004	Lee, Baek-woon	345/89
*	B	US-2003/0193460	10-2003	Lee et al.	345/87
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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